

Special Issue

AI-Driven Decision Support for Systemic Innovation

Message from the Guest Editors

The Special Issue aims to showcase cutting-edge research that combines artificial intelligence technology with decision models, system architecture, and application system innovation. We welcome submissions that highlight methodological breakthroughs, hybrid computing frameworks, and practical applications that utilize artificial intelligence to improve decision-making efficiency, transparency, and adaptability. Potential topics include optimization and simulation empowered by artificial intelligence, intelligent human-machine collaboration, IoT and blockchain-enhanced decision support systems (DSSs), applications of artificial intelligence in healthcare and medical informatics, as well as in engineering design, industrial systems, and sustainable intelligent environments.

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